COMPLIANT

FREE



E Series Power MOSFET With Fast Body Diode and Low Gate Charge

TO-220AB

PRODUCT SUMMARY				
V_{DS} (V) at T_J max.	650			
R _{DS(on)} typ. (Ω) at 25 °C	V _{GS} = 10 V	0.127		
Q _g (Max.) (nC)	75			
Q _{gs} (nC)	17			
Q _{gd} (nC)	19			
Configuration	Single			

N-Channel MOSFET

FEATURES

- Reduced figure-of-merit (FOM): Ron x Qa
- Fast body diode MOSFET using E series technology
- Reduced t_{rr}, Q_{rr}, and I_{RRM}
- Increased robustness due to low Q_{rr}
- Low input capacitance (C_{iss})
- · Reduced switching and conduction losses
- Avalanche energy rated (UIS)
- Material categorization: for definitions of compliance please see <u>www.vishav.com/doc?99912</u>

APPLICATIONS

- Telecommunications
 - Server and telecom power supplies
- Computing
 - ATX power supplies
- Industrial
 - Welding
 - Induction heating
 - Battery chargers
 - Uninterruptible power supplies (UPS)
- · Renewable energy
 - String PV inverters

ORDERING INFORMATION				
Package	TO-220AB			
Lead (Pb)-free and halogen-free	SiHP25N60EFL-BE3 ^a			
	SiHP25N60EFL-GE3			

Note

a. "-BE3" denotes alternate manufacturing location

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V_{DS}	600	V	
Gate-source voltage			V_{GS}	± 30	1	
Continuous drain current (T _J = 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I _D	25		
	V _{GS} at 10 V	T _C = 100 °C		16	Α	
Pulsed drain current ^a			I _{DM}	61		
Linear derating factor				2	W/°C	
Single pulse avalanche energy b			E _{AS}	353	mJ	
Maximum power dissipation			P_{D}	250	W	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C		
Drain-source voltage slope	T _J = 125 °C		d\//dt 70		1//	
Reverse diode dV/dt ^d		dV/dt	15	V/ns		
Soldering recommendations (peak temperature) c	For 10 s			300	°C	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature
- b. V_{DD} = 140 V, starting T_J = 25 °C, L = 28.2 mH, R_q = 25 Ω , I_{AS} = 5 A
- c. 1.6 mm from case

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d. $I_{SD} \leq I_{D}$, dI/dt = 100 A/ μs , starting $T_{J} = 25$ °C

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	0.5	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							,
Drain-source breakdown voltage	V _{DS}	V _{GS} =	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 10 mA		0.69	-	V/°C
Gate-source threshold Voltage (N)	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		-	5.0	V
Coto pouros loskogo		V _{GS} = ± 20 V		-	-	± 100	nA
Gate-source leakage	I _{GSS}	,	$V_{GS} = \pm 30 \text{ V}$	-	-	± 1	μΑ
Zava gata valtaga dvain avyvant		V _{DS} =	$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$		-	1	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 480 V	', V _{GS} = 0 V, T _J = 125 °C	-	-	500	μA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 12.5 A	-	0.127	0.146	Ω
Forward transconductance	9 _{fs}	V _{DS} = 30 V, I _D = 12.5 A		-	11.3	-	S
Dynamic							
Input capacitance	C _{iss}	$V_{GS} = 0 V$,		-	2274		pF
Output capacitance	C _{oss}	1	$V_{DS} = 0.0$, $V_{DS} = 100 \text{ V}$,		137	-	
Reverse transfer capacitance	C _{rss}	f = 1 MHz		-	4	-	
Effective output capacitance, energy related ^a	C _{o(er)}	V _{DS} = 0 V to 480 V, V _{GS} = 0 V		-	79	-	
Effective output capacitance, time related ^b	C _{o(tr)}			-	330	-	
Total gate charge	Qg			-	50	75	
Gate-source charge	Q _{gs}	V _{GS} = 10 V	$I_D = 12.5 \text{ A}, V_{DS} = 480 \text{ V}$	-	17	-	nC
Gate-drain charge	Q _{gd}				19	-	1
Turn-on delay time	t _{d(on)}			-	25	50	
Rise time	t _r	V _{DD} = 480 V, I _D = 12.5 A,		-	39	68	ns
Turn-off delay time	t _{d(off)}	$R_g =$	$R_g = 9.1 \Omega, V_{GS} = 10 V$		47	94	
Fall time	t _f	1		-	21	42	
Gate input resistance	R_g	f = 1 MHz, open drain		0.4	0.7	1.4	Ω
Drain-Source Body Diode Characteristic	es						
Continuous source-drain diode current	I _S	MOSFET sym showing the	MOSFET symbol		-	25	
Pulsed diode forward current	I _{SM}	integral reverse p - n junction diode		-	-	61	- A
Diode forward voltage	V _{SD}	T _J = 25 °C, I _S = 12.5 A, V _{GS} = 0 V		-	0.9	1.2	V
Reverse recovery time	t _{rr}		0 -2 -5, 3 -2-2 -5, 100 -0 -1		138	276	ns
Reverse recovery charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}$, $I_F = I_S = 12.5 \text{A}$, $dI/dt = 100 \text{A/}\mu\text{s}$, $V_R = 25 \text{V}$		-	0.8	1.6	μC
Reverse recovery current	I _{RRM}			-	11	-	A

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}
- b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

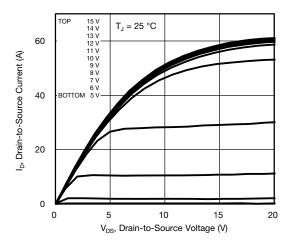


Fig. 1 - Typical Output Characteristics

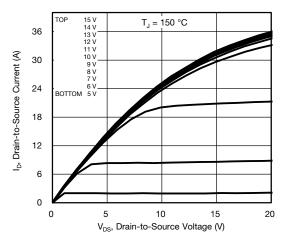


Fig. 2 - Typical Output Characteristics

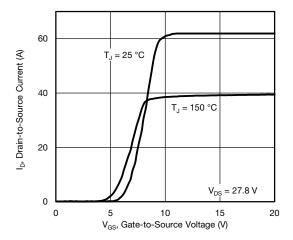


Fig. 3 - Typical Transfer Characteristics

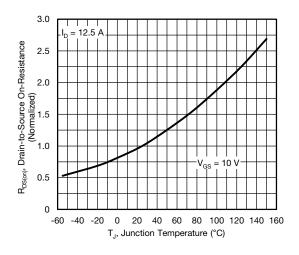


Fig. 4 - Normalized On-Resistance vs. Temperature

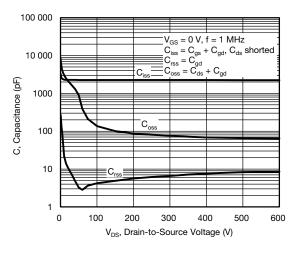


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

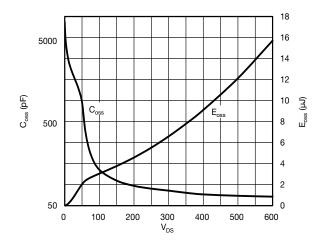


Fig. 6 - C_{OSS} and E_{OSS} vs. V_{DS}



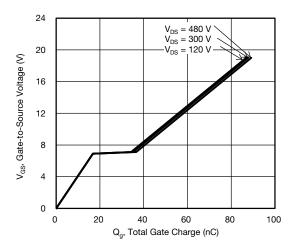


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

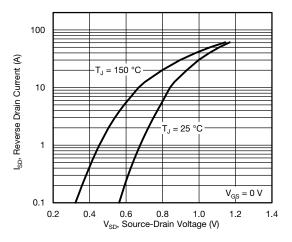


Fig. 8 - Typical Source-Drain Diode Forward Voltage

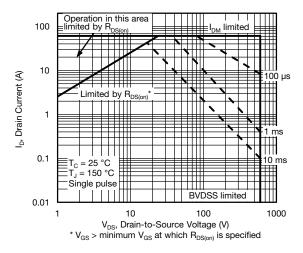


Fig. 9 - Maximum Safe Operating Area

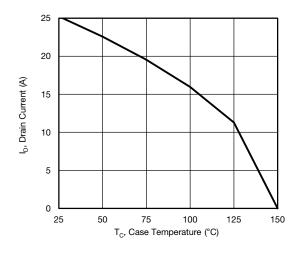


Fig. 10 - Maximum Drain Current vs. Case Temperature

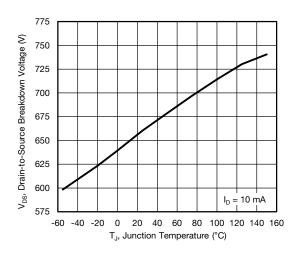


Fig. 11 - Typical Drain-to-Source Voltage vs. Temperature



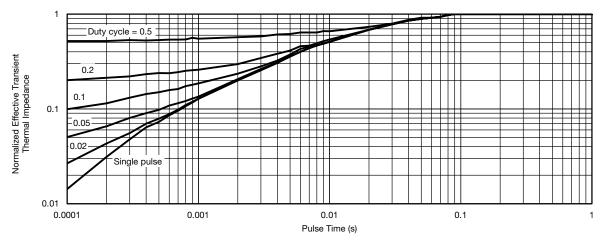


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

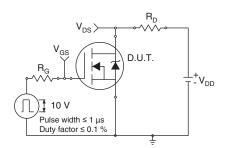


Fig. 13 - Switching Time Test Circuit

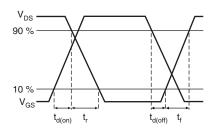


Fig. 14 - Switching Time Waveforms

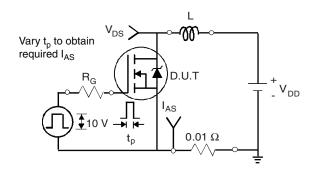


Fig. 15 - Unclamped Inductive Test Circuit

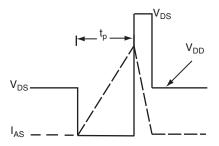


Fig. 16 - Unclamped Inductive Waveforms

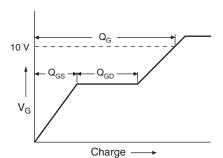


Fig. 17 - Basic Gate Charge Waveform

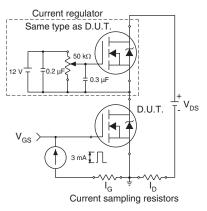
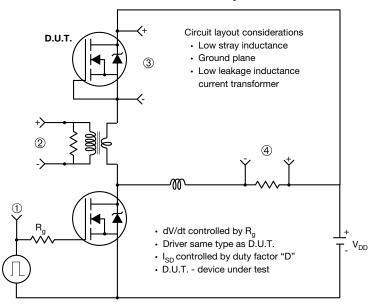


Fig. 18 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



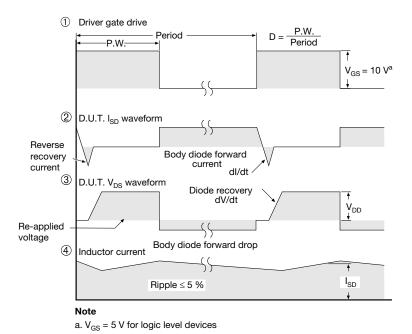


Fig. 19 - For N-Channel

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